

IDS - 08/25/2003

PTO/SB/08a (08-03)

Approved for use through 07/31/2008. OMB 0851-0031

U.S. Patent and Trademark Office; U.S. DEPARTMENT OF COMMERCE

Under the Paperwork Reduction Act of 1995, no persons are required to respond to a collection of information unless it contains a valid OMB control number.

Substitute for form 1449A/PTO

Complete If KnownApplication Number **10/647,556**Filing Date **August 25, 2003**First Named Inventor **Sanjay Rastogi**Art Unit **1762**Examiner Name **Marianne Padgett**Attorney Docket Number **P03212****INFORMATION DISCLOSURE
STATEMENT BY APPLICANT**

(Use as many sheets as necessary)

Sheet

1

of 1

U. S. PATENT DOCUMENTS						
Examiner Initials*	Cite No.*	Document Number		Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number-Kind Code ² // known				
MLP	AA	US- 4055378	B1	10/25/1977	Feneberg et al.	
	AB	US- 4122942	B1	10/31/1978	Wolfson	
	AC	US- 4143949	B1	03/13/1979	Chen	
	AD	US- 4168112	B1	09/18/1979	Ellis et al.	
	AE	US- 4214014	B1	07/22/1980	Hofer et al.	
	AF	US- 4287175	B1	09/01/1981	Katz	
	AG	US- 4312575	B1	01/26/1982	Peyman et al.	
	AH	US- 4321261	B1	03/23/1982	Ellis et al.	
	AI	US- 4436730	B1	03/13/1984	Ellis et al.	
	AJ	US- 4632844	B1	12/30/1986	Yanagihara et al.	
	AK	US- 5397848	B1	03/14/1995	Yang et al.	
	AL	US- 5503515	B1	04/02/1996	Moorehead	
•	AM	US- 45700559	B1	12/23/1997	Sheu et al.	5,700,559
	AN	US- 5705583	B1	01/06/1998	Bowers et al.	
	AO	US- 5807636	B1	09/15/1998	Sheu et al.	
	AP	US- 5969793	B1	10/19/1999	Dobner	
MLP	AQ	US- 6502879	B1	01/07/2003	Miyazawa	
See	US-	Attachment 1	none found		in scanned file	

5/22/07
T.T.

FOREIGN PATENT DOCUMENTS

Examiner Initials*	Cite No.*	Foreign Patent Document		Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T ⁶
		Country Code ³ Number ⁴ Kind Code ⁵ // known					
MLP	AY	WO	95/04609	A1	02/16/1995	Seiferling et al.	in English X
MLP	AZ	EP	0963761	A1	12/15/1999	Vanderlaan et al.	X
MLP	BA	WO	94/29756	A2	12/22/1994	Ingenito et al.	X

[Handwritten signatures over the table]

Examiner Signature	/Marianne L. Padgett/	Date Considered	07/26/2006
--------------------	-----------------------	-----------------	------------

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.¹ Applicant's unique citation designation number (optional).² See Kinds Codes of USPTO Patent Documents at www.uspto.gov or MPEP 601.04.³ Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3).⁴ For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document.⁵ Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST.16 if possible.⁶ Applicant is to place a check mark here if English language Translation is attached.

This collection of information is required by 37 CFR 1.97 and 1.98. The information is required to obtain or retain a benefit by the public which is to file (and by the USPTO to process) an application. Confidentiality is governed by 35 U.S.C. 122 and 37 CFR 1.14. This collection is estimated to take 2 hours to complete, including gathering, preparing, and submitting the completed application form to the USPTO. Time will vary depending upon the individual case. Any comments on the amount of time you require to complete this form and/or suggestions for reducing this burden, should be sent to the Chief Information Officer, U.S. Patent and Trademark Office, U.S. Department of Commerce, P.O. Box 1450, Alexandria, VA 22313-1450. DO NOT SEND FEES OR COMPLETED FORMS TO THIS ADDRESS. SEND TO: Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450.

If you need assistance in completing the form, call 1-800-PTO-9199 and select option 2.